

**Search Notes**

Application/Control No.

09/752,644

Examiner

Tse Chen

Applicant(s)/Patent under  
Reexamination

KEDIA ET AL.

Art Unit

2116

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Text search only see search report		TSE